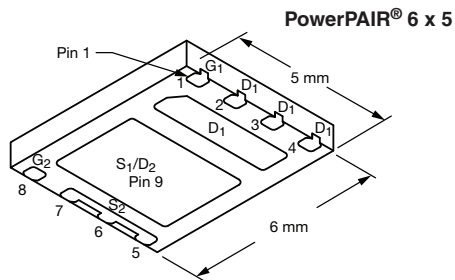




Dual N-Channel 30 V (D-S) MOSFETs

| PRODUCT SUMMARY | | | | |
|-----------------|---------------------|-----------------------------------|--------------------|-----------------------|
| | V _{DS} (V) | R _{DS(on)} (Ω) (Max.) | I _D (A) | Q _g (Typ.) |
| Channel-1 | 30 | 0.0071 at V _{GS} = 10 V | 40 ^a | 10.5 nC |
| | | 0.0089 at V _{GS} = 4.5 V | 40 ^a | |
| Channel-2 | 30 | 0.0030 at V _{GS} = 10 V | 40 ^a | 29 nC |
| | | 0.0035 at V _{GS} = 4.5 V | 40 ^a | |



Ordering Information:
SiZ920DT-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

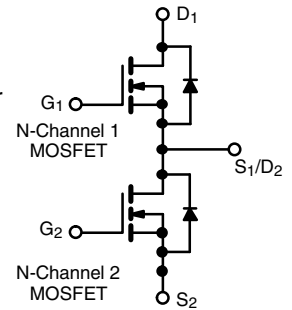
- TrenchFET[®] Power MOSFETs
- 100 % R_g and UIS Tested
- Material categorization:
For definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- CPU Core Power
- Computer Peripherals
- POL
- Synchronous Buck Converter



| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted) | | | | | |
|---|-----------------------------------|------------------------|---------------------|---------------------|---|
| Parameter | Symbol | Channel-1 | Channel-2 | Unit | |
| Drain-Source Voltage | V _{DS} | 30 | | V | |
| Gate-Source Voltage | V _{GS} | ± 20 | | | |
| Continuous Drain Current (T _J = 150 °C) | I _D | T _C = 25 °C | 40 ^a | 40 ^a | A |
| | | T _C = 70 °C | 40 ^a | 40 ^a | |
| | | T _A = 25 °C | 22 ^{b, c} | 32 ^{b, c} | |
| | | T _A = 70 °C | 17 ^{b, c} | 26 ^{b, c} | |
| Pulsed Drain Current (t = 300 μs) | I _{DM} | 70 | 120 | | |
| Continuous Source Drain Diode Current | I _S | T _C = 25 °C | 28 ^a | 28 ^a | |
| | | T _A = 25 °C | 3.6 ^{b, c} | 4.3 ^{b, c} | |
| Single Pulse Avalanche Current | I _{AS} | 25 | 40 | | |
| Single Pulse Avalanche Energy | E _{AS} | 31 | 80 | mJ | |
| Maximum Power Dissipation | P _D | T _C = 25 °C | 39 | 100 | W |
| | | T _C = 70 °C | 25 | 64 | |
| | | T _A = 25 °C | 4.3 ^{b, c} | 5.2 ^{b, c} | |
| | | T _A = 70 °C | 2.8 ^{b, c} | 3.3 ^{b, c} | |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | - 55 to 150 | | °C | |
| Soldering Recommendations (Peak Temperature) ^{d, e} | | 260 | | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|-------------------|-----------|------|-----------|------|------|
| Parameter | Symbol | Channel-1 | | Channel-2 | | Unit |
| | | Typ. | Max. | Typ. | Max. | |
| Maximum Junction-to-Ambient ^{b, f} | R _{thJA} | 23 | 29 | 19 | 24 | °C/W |
| Maximum Junction-to-Case (Drain) | R _{thJC} | 2.5 | 3.2 | 1 | 1.25 | |

Notes:

- Package limited - T_C = 25 °C.
- Surface mounted on 1" x 1" FR4 board.
- t = 10 s.
- See solder profile (www.vishay.com/doc?73257). The PowerPAIR is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under steady state conditions is 65 °C/W for channel-1 and 55 °C/W for channel-2.

| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | | | |
|---|-------------------------|---|--|------|--------|-----------|----------------------|----|
| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit | | |
| Static | | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | Ch-1 | 30 | | | V | |
| | | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | Ch-2 | 30 | | | | |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | $I_D = 250\text{ }\mu\text{A}$ | Ch-1 | | 34 | | mV/ $^\circ\text{C}$ | |
| | | $I_D = 250\text{ }\mu\text{A}$ | Ch-2 | | 31 | | | |
| $V_{GS(th)}$ Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | $I_D = 250\text{ }\mu\text{A}$ | Ch-1 | | - 5.2 | | | |
| | | $I_D = 250\text{ }\mu\text{A}$ | Ch-2 | | - 6.1 | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | Ch-1 | 1.2 | | 2.5 | V | |
| | | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | Ch-2 | 1 | | 2.2 | | |
| Gate Source Leakage | I_{GSS} | $V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$ | Ch-1 | | | ± 100 | nA | |
| | | | Ch-2 | | | ± 100 | | |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$ | Ch-1 | | | 1 | μA | |
| | | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$ | Ch-2 | | | 1 | | |
| | | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$ | Ch-1 | | | 5 | | |
| | | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$ | Ch-2 | | | 5 | | |
| On-State Drain Current ^b | $I_{D(on)}$ | $V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$ | Ch-1 | 20 | | | A | |
| | | $V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$ | Ch-2 | 25 | | | | |
| Drain-Source On-State Resistance ^b | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}, I_D = 18.9\text{ A}$ | Ch-1 | | 0.0059 | 0.0071 | Ω | |
| | | $V_{GS} = 10\text{ V}, I_D = 20\text{ A}$ | Ch-2 | | 0.0025 | 0.0030 | | |
| | | $V_{GS} = 4.5\text{ V}, I_D = 16.9\text{ A}$ | Ch-1 | | 0.0074 | 0.0089 | | |
| | | $V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$ | Ch-2 | | 0.0029 | 0.0035 | | |
| Forward Transconductance ^b | g_{fs} | $V_{DS} = 10\text{ V}, I_D = 18.9\text{ A}$ | Ch-1 | | 66 | | S | |
| | | $V_{DS} = 10\text{ V}, I_D = 20\text{ A}$ | Ch-2 | | 140 | | | |
| Dynamic^a | | | | | | | | |
| Input Capacitance | C_{iss} | Channel-1 $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | Ch-1 | | 1260 | | pF | |
| | | | Ch-2 | | 3600 | | | |
| Output Capacitance | C_{oss} | | Channel-2 $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | Ch-1 | | 260 | | |
| | | | | Ch-2 | | 660 | | |
| Reverse Transfer Capacitance | C_{rss} | Channel-1 $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | | Ch-1 | | 115 | | |
| | | | | Ch-2 | | 305 | | |
| Total Gate Charge | Q_g | | $V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 18.9\text{ A}$ | Ch-1 | | 22.3 | 35 | nC |
| | | | | Ch-2 | | 60 | 110 | |
| | | $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 18.9\text{ A}$ | Ch-1 | | 10.5 | 16 | | |
| | | | Ch-2 | | 29 | 51 | | |
| Gate-Source Charge | Q_{gs} | Channel-2 $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$ | Ch-1 | | 5.1 | | | |
| | | | Ch-2 | | 10 | | | |
| Gate-Drain Charge | Q_{gd} | | Ch-1 | | 2.8 | | | |
| | | | Ch-2 | | 9.5 | | | |
| Gate Resistance | R_g | $f = 1\text{ MHz}$ | Ch-1 | 0.3 | 1.6 | 3.2 | Ω | |
| | | | Ch-2 | 0.1 | 0.6 | 1.2 | | |

Notes:

- a. Guaranteed by design, not subject to production testing.
b. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.



| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | | | |
|--|--------------|---|--|------|------|------|----|----|
| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit | | |
| Dynamic^a | | | | | | | | |
| Turn-On Delay Time | $t_{d(on)}$ | Channel-1 $V_{DD} = 15\text{ V}$, $R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}$, $V_{GEN} = 4.5\text{ V}$, $R_g = 1\ \Omega$ | Ch-1 | | 15 | 23 | ns | |
| | | | Ch-2 | | 30 | 60 | | |
| Rise Time | t_r | | Ch-1 | | 18 | 30 | | |
| | | | Ch-2 | | 35 | 70 | | |
| Turn-Off Delay Time | $t_{d(off)}$ | Channel-2 $V_{DD} = 15\text{ V}$, $R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}$, $V_{GEN} = 4.5\text{ V}$, $R_g = 1\ \Omega$ | Ch-1 | | 15 | 23 | | |
| | | | Ch-2 | | 35 | 70 | | |
| Fall Time | t_f | | Ch-1 | | 10 | 20 | | |
| | | | Ch-2 | | 12 | 25 | | |
| Turn-On Delay Time | $t_{d(on)}$ | Channel-1 $V_{DD} = 15\text{ V}$, $R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_g = 1\ \Omega$ | Ch-1 | | 4 | 8 | | |
| | | | Ch-2 | | 12 | 25 | | |
| Rise Time | t_r | | Ch-1 | | 11 | 25 | | |
| | | | Ch-2 | | 12 | 25 | | |
| Turn-Off Delay Time | $t_{d(off)}$ | Channel-2 $V_{DD} = 15\text{ V}$, $R_L = 1.5\ \Omega$ $I_D \cong 10\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_g = 1\ \Omega$ | Ch-1 | | 18 | 30 | | |
| | | | Ch-2 | | 35 | 70 | | |
| Fall Time | t_f | | Ch-1 | | 8 | 16 | | |
| | | | Ch-2 | | 10 | 20 | | |
| Drain-Source Body Diode Characteristics | | | | | | | | |
| Continuous Source-Drain Diode Current | I_S | $T_C = 25\text{ }^\circ\text{C}$ | Ch-1 | | | 40 | A | |
| | | | Ch-2 | | | 40 | | |
| Pulse Diode Forward Current ^a | I_{SM} | | Ch-1 | | | 70 | | |
| | | | Ch-2 | | | 120 | | |
| Body Diode Voltage | V_{SD} | $I_S = 10\text{ A}$, $V_{GS} = 0\text{ V}$ | Ch-1 | | 0.8 | 1.2 | V | |
| | | $I_S = 10\text{ A}$, $V_{GS} = 0\text{ V}$ | Ch-2 | | 0.8 | 1.2 | | |
| Body Diode Reverse Recovery Time | t_{rr} | Channel-1 $I_F = 10\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25\text{ }^\circ\text{C}$ | Ch-1 | | 17 | 30 | ns | |
| | | | Ch-2 | | 36 | 70 | | |
| Body Diode Reverse Recovery Charge | Q_{rr} | | Channel-2 $I_F = 10\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25\text{ }^\circ\text{C}$ | Ch-1 | | 10 | 20 | nC |
| | | | | Ch-2 | | 36 | 70 | |
| Reverse Recovery Fall Time | t_a | | Ch-1 | | 10 | | ns | |
| | | | Ch-2 | | 20 | | | |
| Reverse Recovery Rise Time | t_b | | Ch-1 | | 7 | | | |
| | | | Ch-2 | | 16 | | | |

Notes:

- a. Guaranteed by design, not subject to production testing.
 b. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.

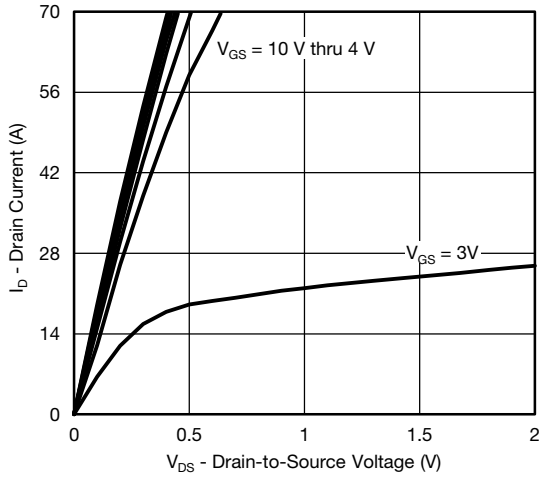
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

SiZ920DT

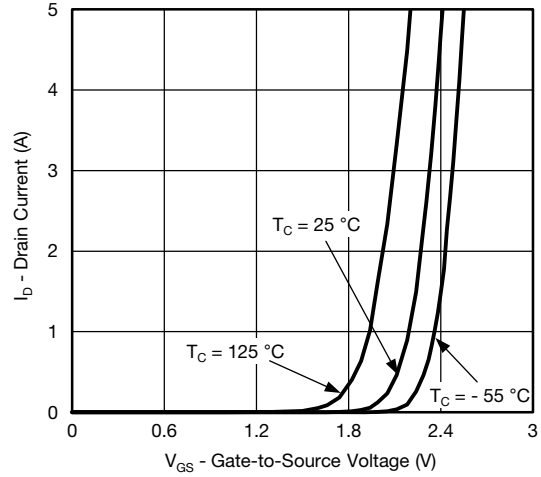
Vishay Siliconix



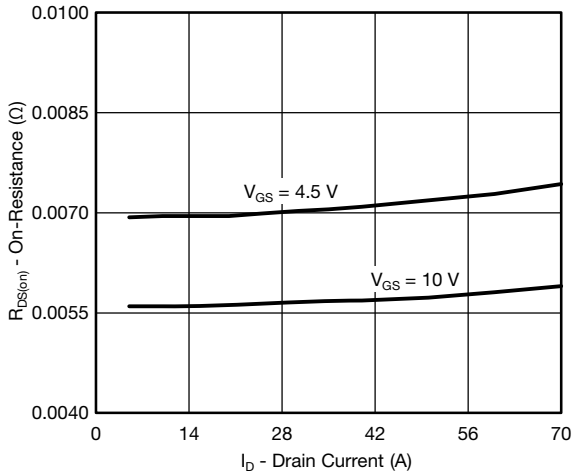
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



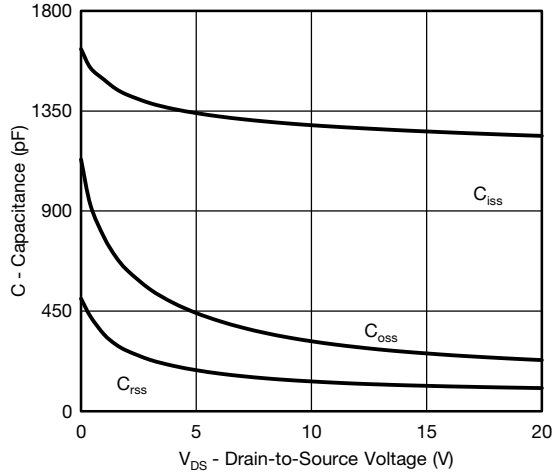
Output Characteristics



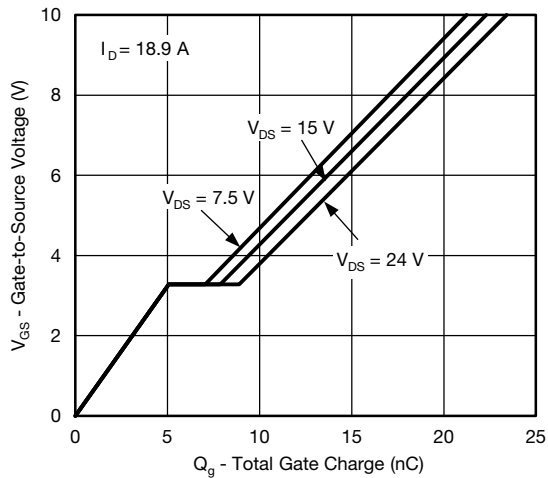
Transfer Characteristics



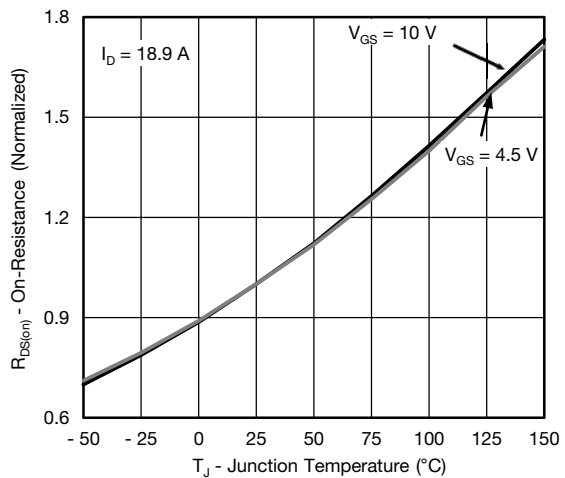
On-Resistance vs. Drain Current



Capacitance



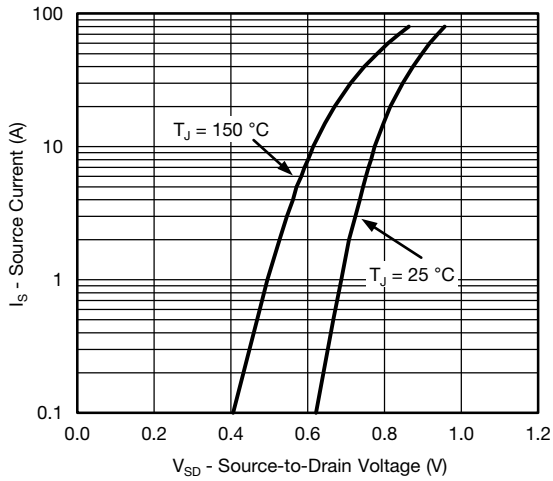
Gate Charge



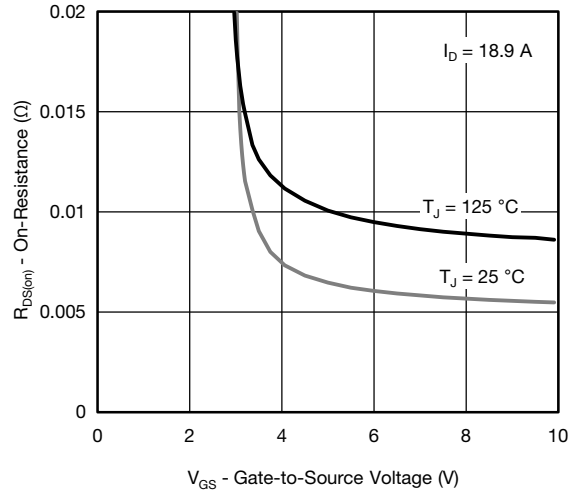
On-Resistance vs. Junction Temperature



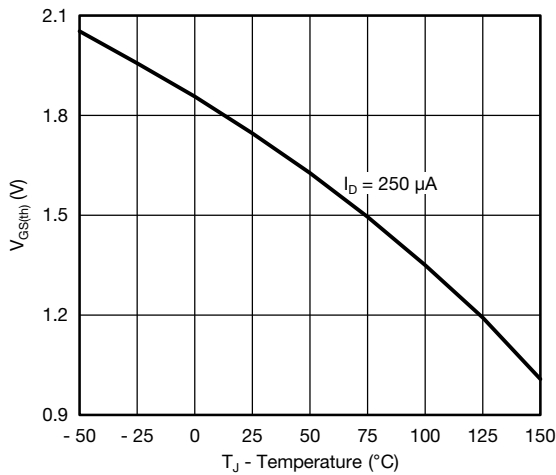
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



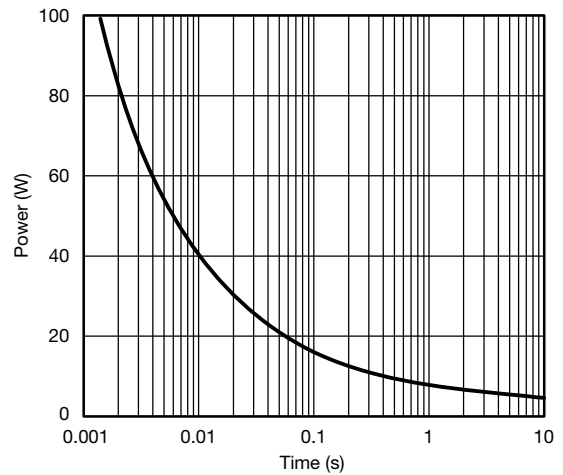
Source-Drain Diode Forward Voltage



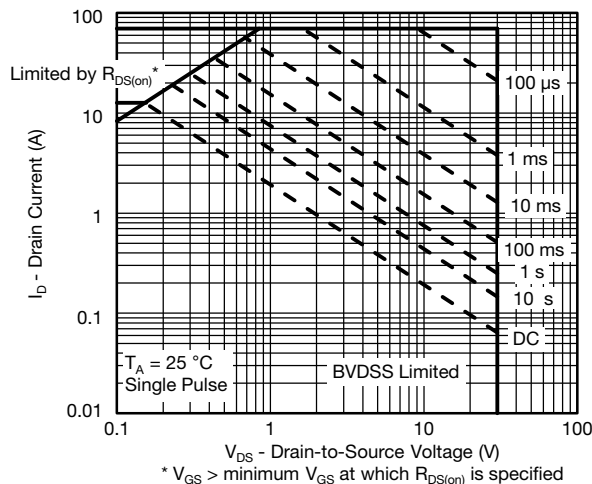
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

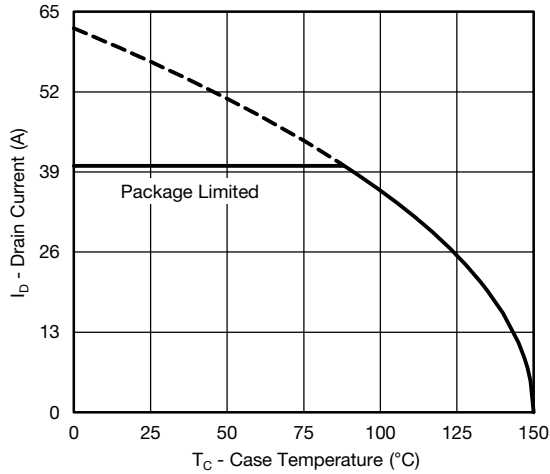


Single Pulse Power

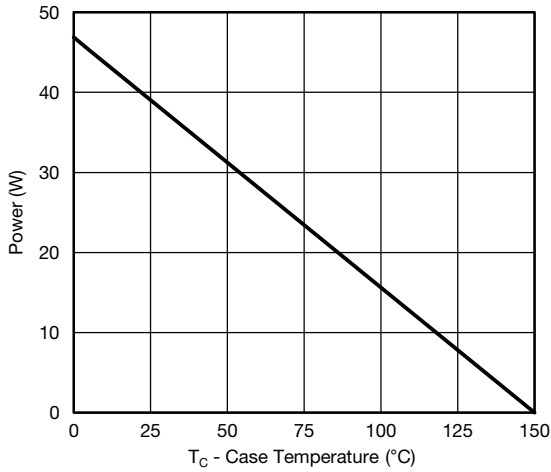


Safe Operating Area, Junction-to-Ambient

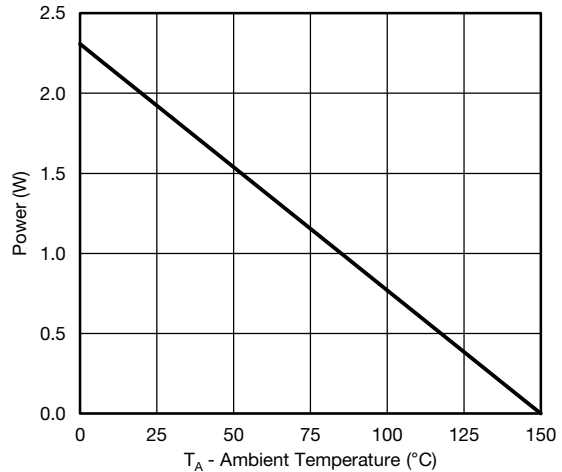
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



Power, Junction-to-Case

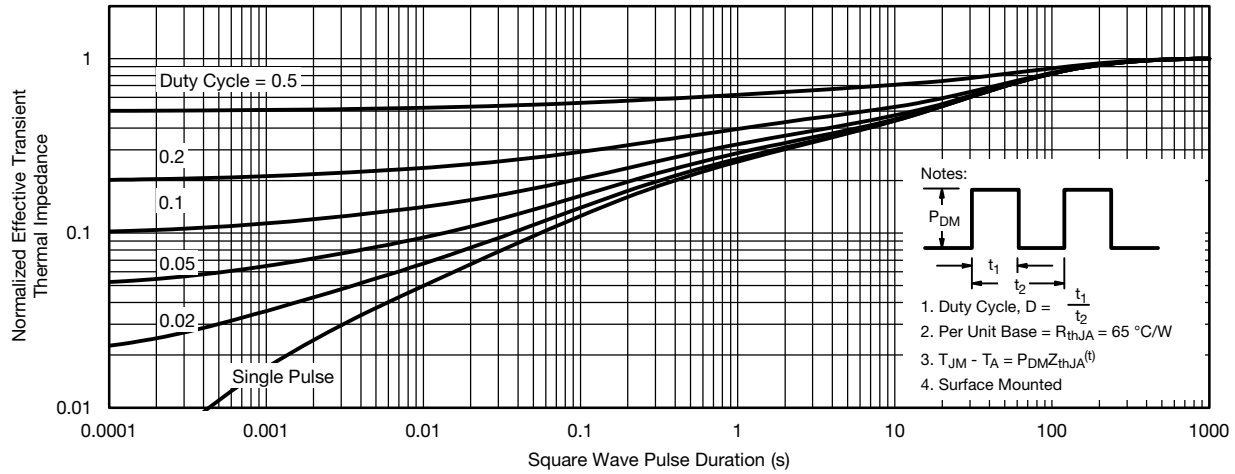


Power, Junction-to-Ambient

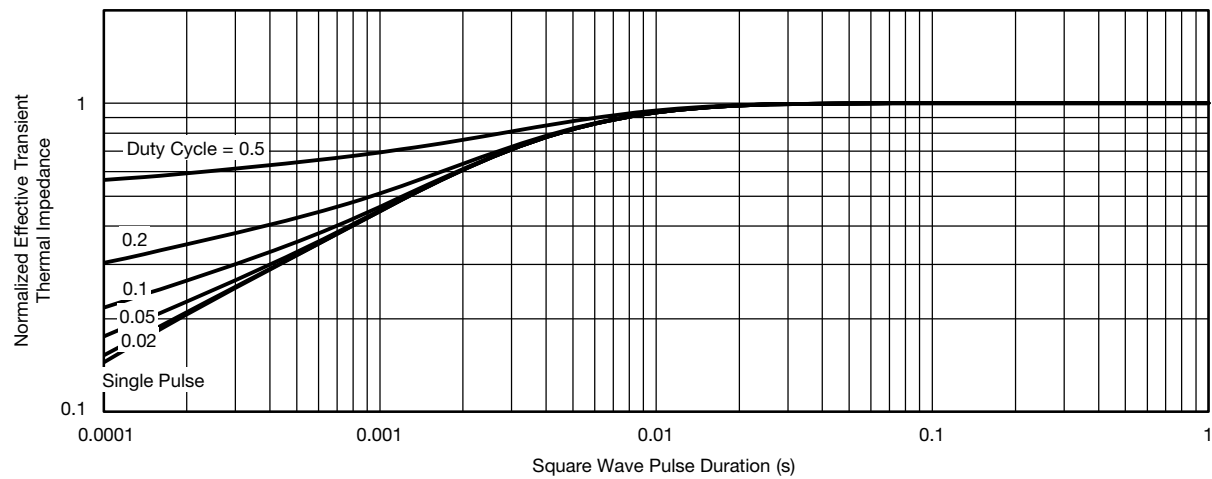
* The power dissipation P_D is based on $T_{J(max)} = 150\text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

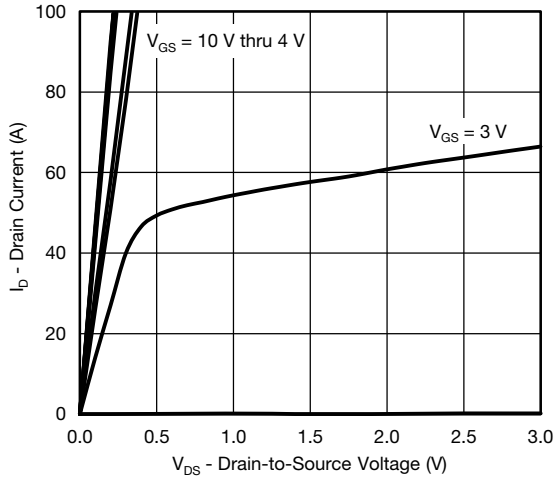


Normalized Thermal Transient Impedance, Junction-to-Ambient

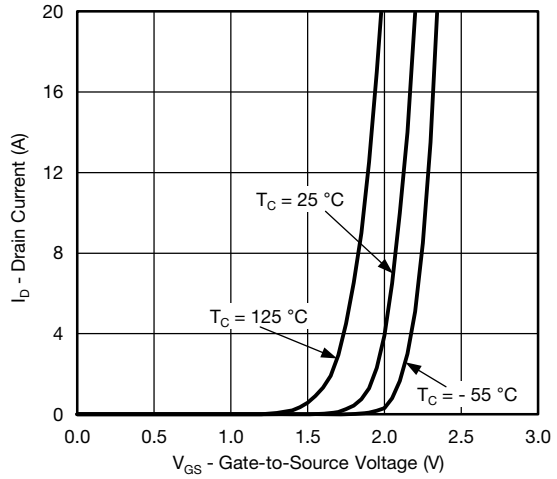


Normalized Thermal Transient Impedance, Junction-to-Case

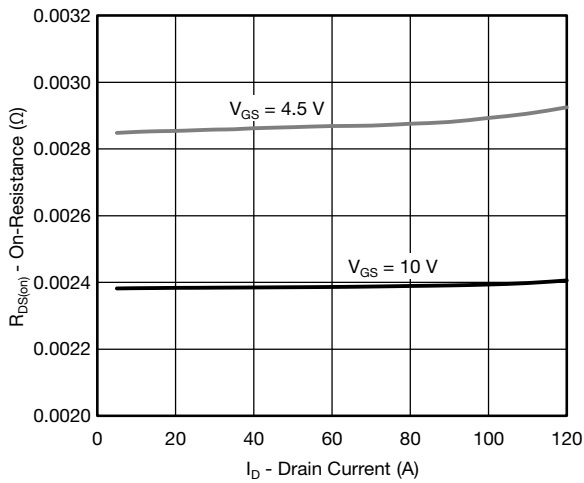
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



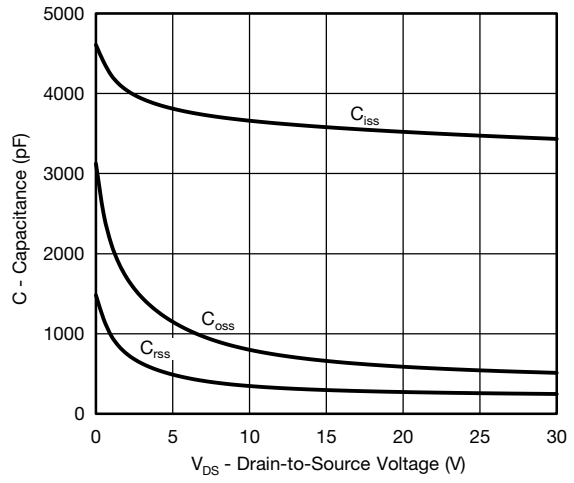
Output Characteristics



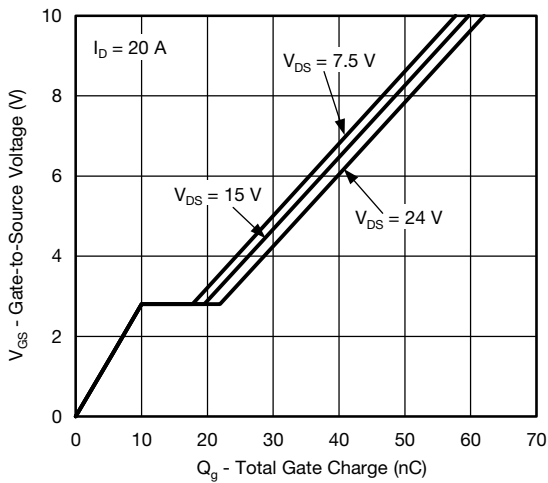
Transfer Characteristics



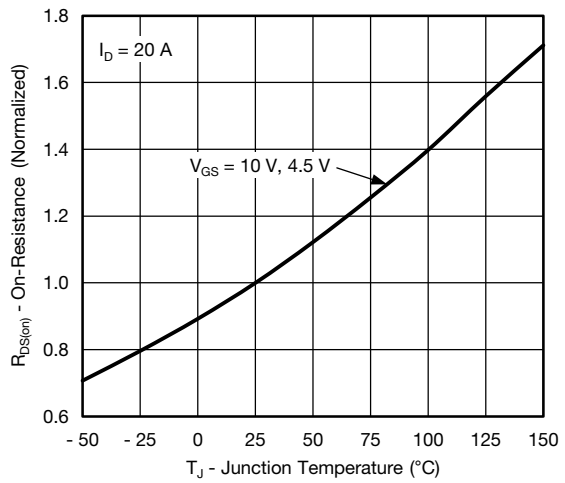
On-Resistance vs. Drain Current



Capacitance



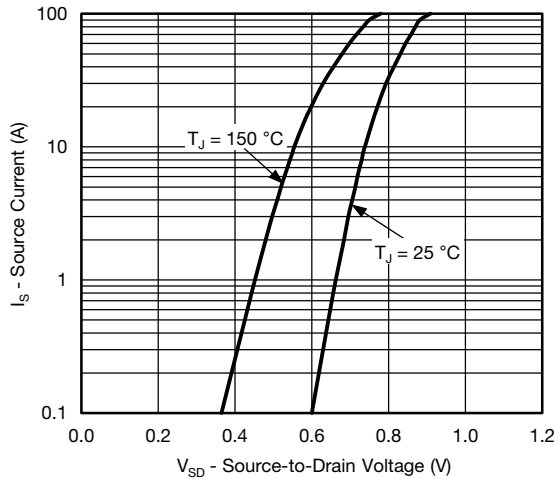
Gate Charge



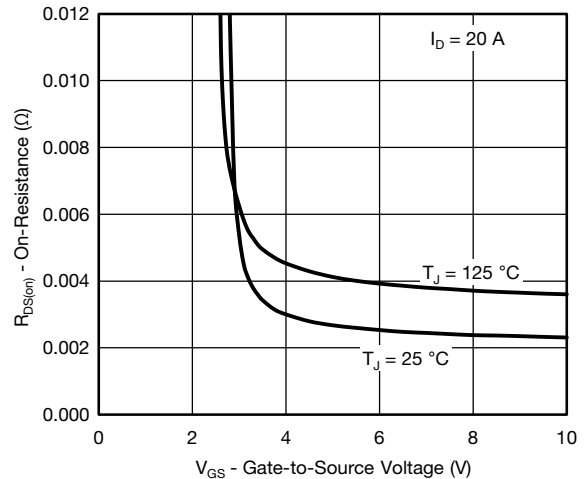
On-Resistance vs. Junction Temperature



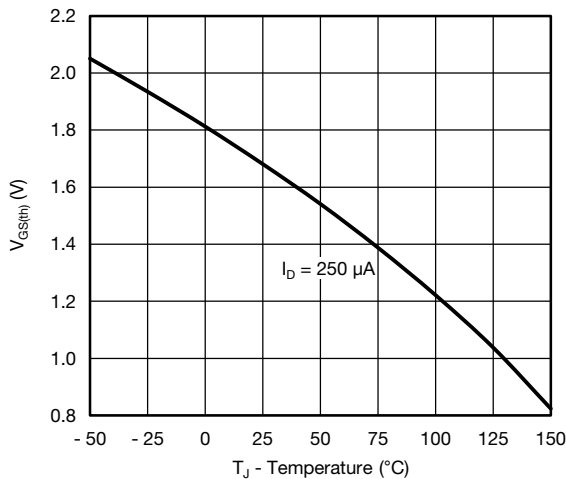
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



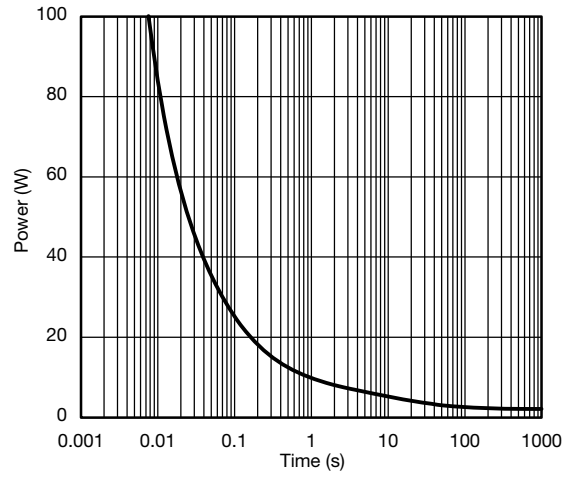
Source-Drain Diode Forward Voltage



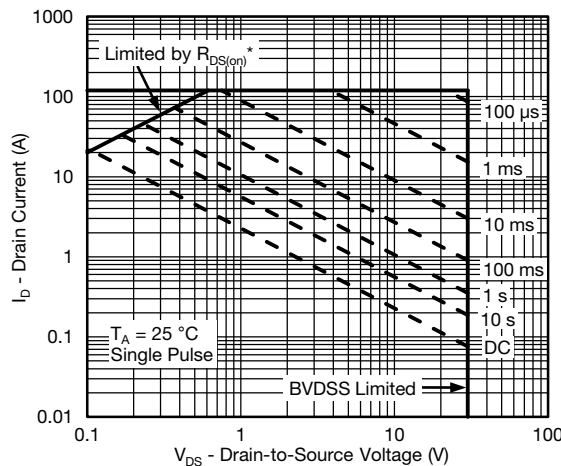
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

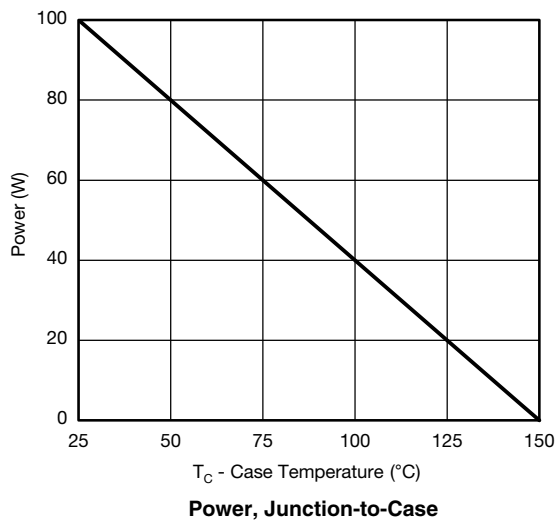
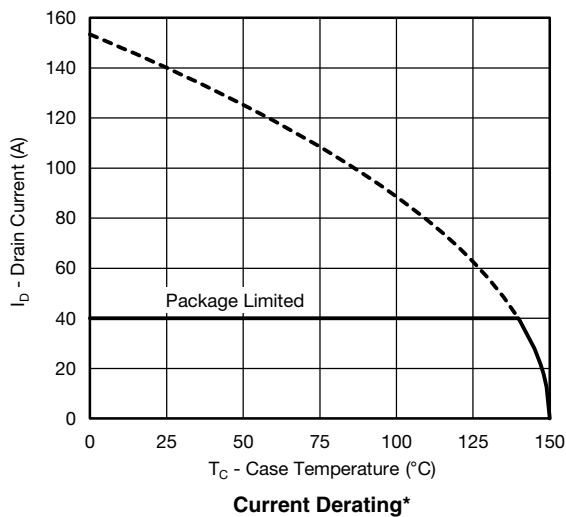


Single Pulse Power



Safe Operating Area, Junction-to-Ambient

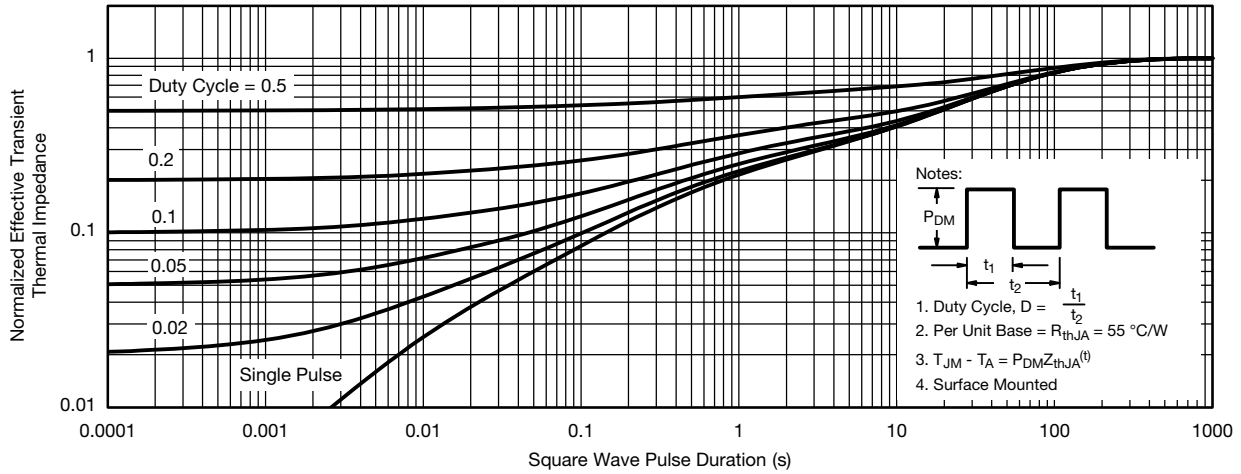
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



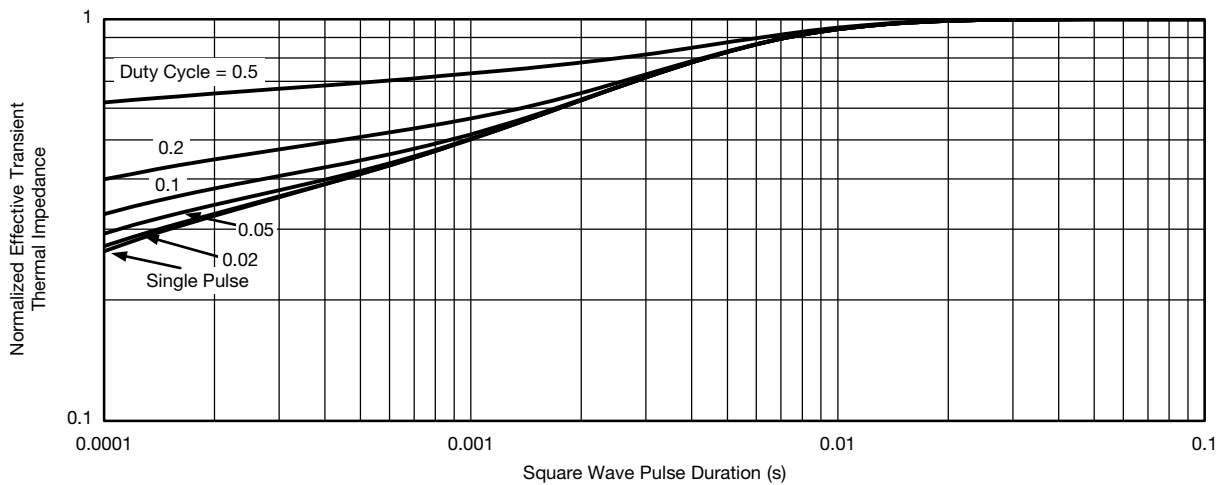
* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

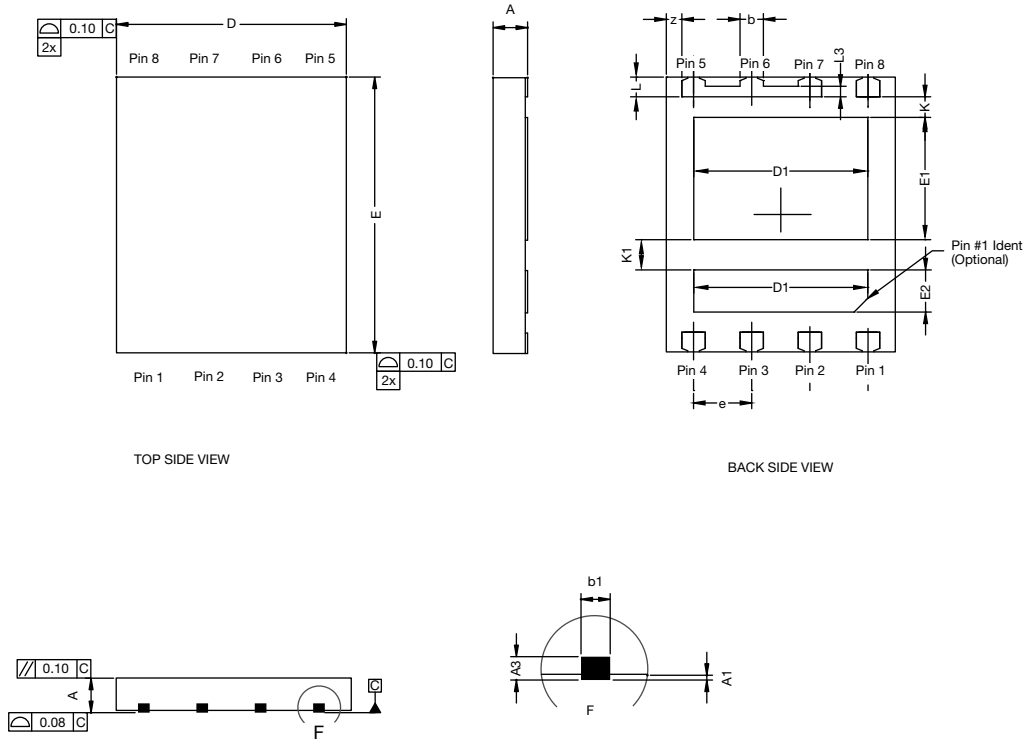


Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63916.



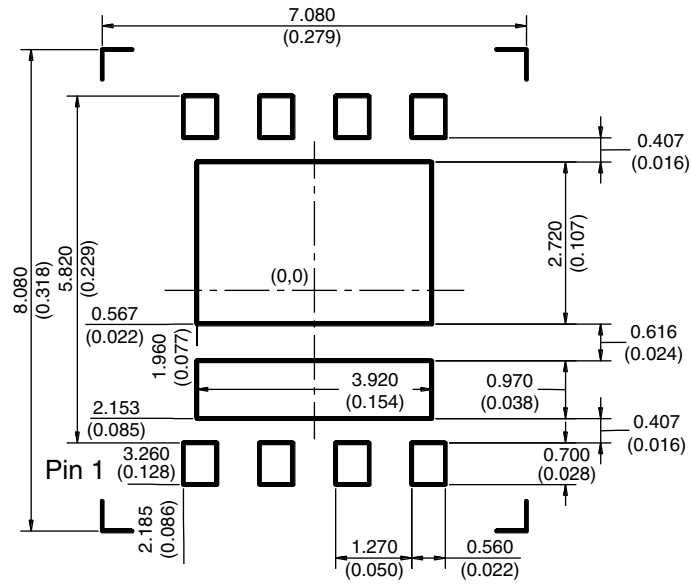
PowerPAIR® 6 x 5 Case Outline



| DIM. | MILLIMETERS | | | INCHES | | |
|------|-------------|------|------|------------|-------|-------|
| | MIN. | NOM. | MAX. | MIN. | NOM. | MAX. |
| A | 0.70 | 0.75 | 0.80 | 0.028 | 0.030 | 0.032 |
| A1 | 0.00 | - | 0.10 | 0.000 | - | 0.004 |
| A3 | 0.20 REF | | | 0.008 REF | | |
| b | 0.51 BSC | | | 0.020 BSC | | |
| b1 | 0.25 BSC | | | 0.010 BSC | | |
| D | 5.00 BSC | | | 0.197 BSC | | |
| D1 | 3.75 | 3.80 | 3.85 | 0.148 | 0.150 | 0.152 |
| E | 6.00 BSC | | | 0.236 BSC | | |
| E1 | 2.62 | 2.67 | 2.72 | 0.103 | 0.105 | 0.107 |
| E2 | 0.87 | 0.92 | 0.97 | 0.034 | 0.036 | 0.038 |
| e | 1.27 BSC | | | 0.005 BSC | | |
| K | 0.45 TYP. | | | 0.018 TYP. | | |
| K1 | 0.66 TYP. | | | 0.026 TYP. | | |
| L | 0.43 BSC | | | 0.017 BSC | | |
| L3 | 0.23 BSC | | | 0.009 BSC | | |
| z | 0.34 BSC | | | 0.013 BSC | | |

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 DWG: 6005

RECOMMENDED MINIMUM PAD FOR PowerPAIR® 6 x 5



Recommended Minimum Pad
Dimensions in mm (inches)



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